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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

OCT 0 3 2006

In re Patent Application of

SAKAI et al

Serial No. 10/805,296

Filed: March 22, 2004

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Examiner: Not Yet Assigned

For: GAS CONCENTRATION DETECTING APPARATUS

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October 3, 2006

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT

Attention is directed to the attached Japanese Office Action in a counterpart of this application and to a copy of each non-U.S. patent document newly cited therein. A Form PTO/SB/08a is also attached.

Official consideration and citation of all identified documents is requested.

Respectfully submitted,

NIXON & VANDERHYE P.C.

By:

Larry S. Nixon Reg. No. 25.640

LSN:jls

1100 North Glebe Road, 8th Floor

Arlington, VA 22201-4714 Telephone: (703) 816-4000

Facsimile: (703) 816-4100

INFORM	IATION DISCHOLER	ATTY. DOCKET NO. SE 2635-206 10		SERIAL NO. 10/805,296			
	CITATION						
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XAMINER			J.S. PATENT DOCUMENTS			FILING	DAT
INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	IF APPR	OPRI
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Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.

Date Considered

*Examiner